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	10527715	CHOI, HAE-YONG
Examiner	Art Unit	
Cruz, Magda	2851	

Cruz, Magda (Assistant Examiner) <i>mc</i> (Date)	10/24/2007	DIANE I. LEE SUPERVISORY PATENT EXAMINER	Total Claims Allowed: 7
<i>Jones</i> (Legal Instruments Examiner)	11/6/07 (Date)	Diane Lee (Primary Examiner) <i>DL</i> (Date)	O.G. Print Claim(s) 1
			O.G. Print Figure 6 and 11